

Application/Control No.	Applicant(s)/Patent under Reexamination
10/613,598	TAKANO, KENICHI
Examiner	Art Unit
Tianjie Chen	2627

SEARCHED							
Class	Subclass	Date	Examiner				
Updated		7/15/2006	TJ				

INT	TERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
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